TOSHIBA BI-DIRECTIONAL TRIODE THYRISTOR SILICON PLANAR TYPE

SM6GZ47,SM6JZ47,SM6GZ47A,SM6JZ47A

AC POWER CONTROL APPLICATIONS

Repetitive Peak Off-State Voltage : V_{DRM} = 400, 600V
 R.M.S ON-State Current : I_T (RMS) = 6A

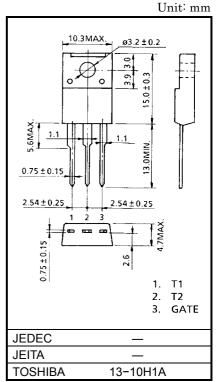
• High Commutating (dv / dt)

• Isolation Voltage : V_{ISOL} = 1500V AC

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MAXIMUM RATINGS

CHARACTERIS	SYMBOL	RATING	UNIT		
Repetitive Peak Off-State Voltage	SM6GZ47 SM6GZ47A	V_{DRM}	400	٧	
and Repetitive Peak Reverse Voltage	SM6JZ47 SM6JZ47A	VDRM	600		
R.M.S On-State Current (Full Sine Waveform Tc	-	I _{T (RMS)}	6	Α	
Peak One Cycle Surge (lzov	60 (50Hz)	Α		
Current (Non-Repetitive)	ITSM	66 (60Hz)		
I ² t Limit Value	I ² t	18	A ² s		
Critical Rate of Rise of C Current (Note 1)	di / dt 50		A / µs		
Peak Gate Power Dissip	P_{GM}	5	W		
Average Gate Power Dis	P _{G (AV)}	0.5	W		
Peak Gate Voltage		V_{FGM}	10	V	
Peak Gate Current		I _{GM}	2	Α	
Junction Temperature		Tj	-40~125	°C	
Storage Temperature Ra	T _{stg}	-40~125	°C		
Isolation Voltage (AC, t =	V _{ISOL}	1500	V		



Weight: 1.7g

Note 1: di / dt test condition

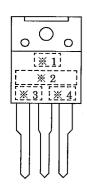
$$\begin{split} &V_{DRM} = 0.5 \times \text{Rated} \\ &I_{TM} \leq 9A \\ &t_{gw} \geq 10 \mu \text{s} \\ &t_{gr} \leq 250 \text{ns} \\ &i_{gp} = I_{GT} \times 2.0 \end{split}$$



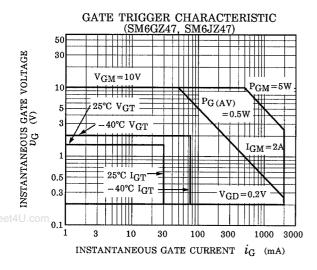
ELECTRICAL CHARACTERISTICS (Ta = 25°C)

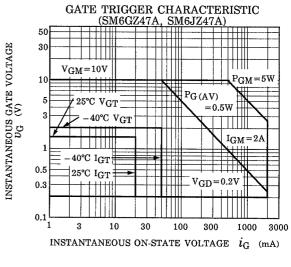
СНА	RACTERIS	TIC		SYMBOL	TEST CONDITION		MIN	TYP.	MAX	UNIT
Repetitive Peak Current	Off-State			I _{DRM}	V _{DRM} = Rated		_	_	20	μA
	T2 (+). Gate (ļ			T2 (+), Gate (+)	_	_	1.5	
Cata Triagar Va			T2 (+), Gate (-)	_	_	1.5	V			
Gate Trigger Vo	itage		III	V_{GT}	$R_L = 20\Omega$ $T_2 (-), Gate (-)$ $T_2 (-), Gate (+)$		_	_	1.5	V
			IV				_	_	_	
			I		$V_D = 12V$ $R_L = 20\Omega$	T2 (+), Gate (+)	_	_	30	- mA
	SM6GZ	47	II			T2 (+), Gate (-)	_	_	30	
J.com	SM6JZ4	SM6JZ47	III			T2 (-), Gate (-)	_	_	30	
Gate Trigger			IV			T2 (-), Gate (+)	_	_	_	
Current SM60			I	- IGT - -		T2 (+), Gate (+)	_	_	20	
	SM6GZ	47A	II			T2 (+), Gate (-)	_	_	20	
	SM6JZ4	17A	III			T2 (-), Gate (-)	_	_	20	
			IV			T2 (-), Gate (+)	_	_	_	
Peak On-State Voltage		V _{TM}	I _{TM} = 9A		_	_	1.5	V		
Gate Non-Trigg	rigger Voltage V _{GD} V _D = Rated, Tc = 125°C		0.2	_	_	V				
Holding Current				lΗ	V _D = 12V, I _{TM} = 1A		_	_	50	mA
Thermal Resista	Thermal Resistance R _{th (j-c)} Junction to Case		se	_	_	3.8	°C/W			
		SM60 SM6J		dv / dt	V _{DRM} = Rated, T _i = 125°C		_	300	_	- V / μs
Voltage	5		GZ47A IZ47A	uv / ut	Exponential Rise		_	200	_	ν / μS
Rise of Off-State Voltage at SM6		SM60 SM6J		(dy / dt) c	$(dv / dt) c$ $V_{DRM} = 400V, T_j = 125^{\circ}C$ $(di / dt) c = -3.3A / ms$		10	_	_	- V / μs
			GZ47A IZ47A	(uv / ut) C			4	_	_	

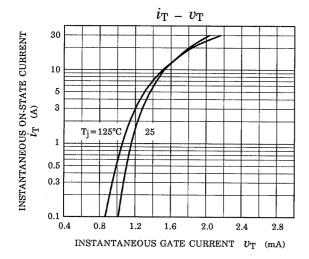
MARKING

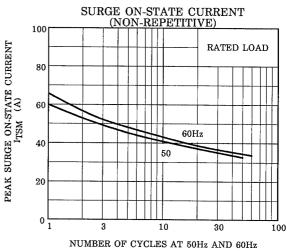


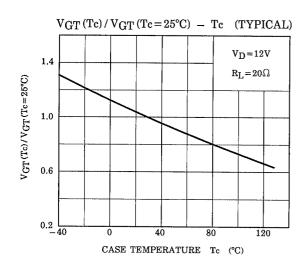
* NUMBER		SYMBOL	MARK	
* 1	TOSHIBA PRODUCT MARK		7	
* 2		SM6GZ47, SM6GZ47A	M6GZ47	
2	TYPE	SM6JZ47, SM6JZ47A	M6JZ47	
* 3		SM6GZ47A, SM6JZ47A	Α	
* 4	Lot Number Month (Starting from Alphabet A) Year (Last Decimal Digit of the Current Year)		Example 8A : January 1998 8B : Febrary 1998 8L : December 1998	

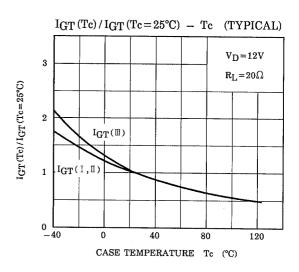


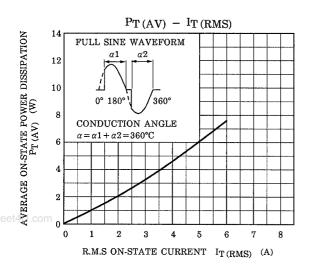


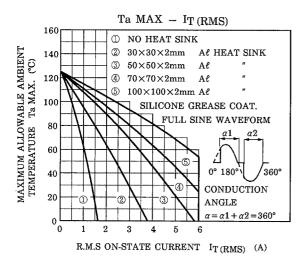


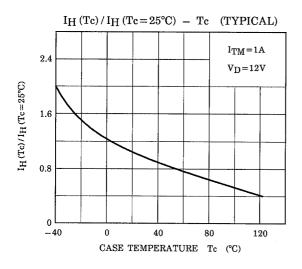


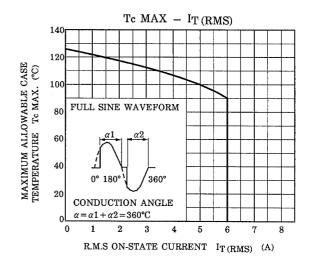


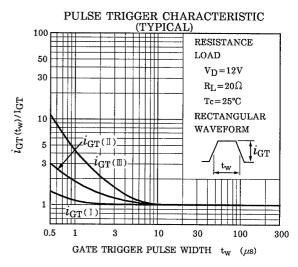


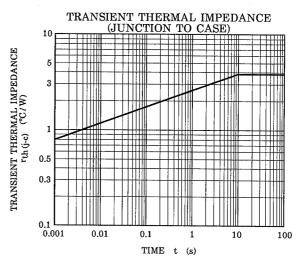












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